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Amendments to the claims

- 1 (Original): A measuring apparatus, comprising:
 - a light source for producing light beams for at least two optical channels; and said optical channels each including:
 - an interferometer for receiving one said light beam and providing therefrom a reference beam and a measurement beam;
 - a reflective target for receiving and redirecting said measurement beam;
 - a beam splitter for receiving the redirected said measurement beam and providing therefrom a first portion and a second portion;
 - a detector for sensing said first portion and producing a detector signal based thereon; said interferometer further for receiving said second portion of said measurement beam and combining said second portion with said reference beam to form a result beam; and
 - a receiver for sensing said result beam and producing a receiver signal based thereon.
- 2 (Original): The measuring apparatus of claim 1, wherein said light source includes a laser diode.
- 3 (Original): The measuring apparatus of claim 1, wherein said light source includes a single light producing unit, a splitter and a bender for producing said light beams.
- 4 (Original): The measuring apparatus of claim 1, wherein said light source includes a plurality of light producing units, one per each said optical channel.
- 5 (Original): The measuring apparatus of claim 1, wherein said interferometers and said beam splitters employ polarization.
- 6 (Original): The measuring apparatus of claim 1, wherein said reflective targets are retroreflectors.

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- 7 (Original): The measuring apparatus of claim 1, wherein said detectors are position sensitive detectors.
- 8 (Original): The measuring apparatus of claim 1, wherein said detectors include at least on member of the set consisting of bi-cell photo diode units, quad-cell photo diode units, and photo diode arrays.
- 9 (Original): The measuring apparatus of claim 1, wherein said receivers include photo diodes.
- 10 (Original): The measuring apparatus of claim 1, further comprising: a processing system for processing said detector signals and said receiver signals into position data suitable for communication to an external system.
- 11 (Original): The measuring apparatus of claim 10, wherein:
 - said light source includes a modulator to produce said light beams including a modulation characteristic; and
 - said processing system includes a demodulator and processes at least one of said detector signals and said receiver signals with phase sensitive detection.
- 12 (Original): A measuring apparatus, comprising:
 - means for producing light beams for at least two optical channels; and said optical channels each including:
 - interferometer means for receiving one said light beam and providing therefrom a reference beam and a measurement beam;
 - means for receiving and redirecting said measurement beam;
 - splitter means for receiving the redirected said measurement beam and providing therefrom a first portion and a second portion;
 - detector means for sensing said first portion and producing a detector signal based thereon;
 - said interferometer means further for receiving said second portion of said measurement

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beam and combining said second portion with said reference beam to form a result beam; and

receiver means for sensing said result beam and producing a receiver signal based thereon.

13 (Original): The measuring apparatus of claim 12, wherein:

said means for producing light beams includes:

means for producing an initial beam;

means for splitting said initial beam into a first beam and at least one secondary beam; and

bender means for directing said secondary beams in parallel with said first beam, thereby producing said light beams for said at least two optical channels.

14 (Original): The measuring apparatus of claim 12, wherein:

said interferometers include means for polarizing said measurement beams; and said splitter means includes means for separating with polarization, thereby permitting providing said first portions and said second portions of said measurement beams based on respective polarization characteristics.

- 15 (Original): The measuring apparatus of claim 12, further comprising:

 processing means for processing said detector signals and said receiver signals into position data suitable for communication to an external system.
- 16 (Currently amended): The measuring apparatus of claim 10 12, wherein:

said means for producing light beams includes modulating to produce said light beams including a modulation characteristic; and

said processing means includes demodulating means to permit processing at least one of said detector signals and said receiver signals with phase sensitive detection.

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- 17 (Original): A method for measuring positional information about a target, the method comprising the steps of:
 - (a) producing light beams for at least two optical channels; and in each said optical channel:
 - (b) receiving a said light beam and providing therefrom a reference beam and a measurement beam;
 - (c) receiving at and redirecting said measurement beam from the target;
 - (d) receiving the redirected said measurement beam and providing therefrom a first portion and a second portion;
 - (e) producing a detector signal based on said first portion;
 - (f) combining said second portion with said reference beam to form a result beam;
 - (g) producing a receiver signal based on said result beam; and
 - (h) processing said detector signals and said receiver signals into position data suitable for communication to an external system.
- 18 (Original): The method of claim 17, wherein:
 - said step (b) includes polarizing said measurement beams; and said step (d) includes separating said first portions from said second portions based on polarization.
- 19 (Original): The method of claim 18, wherein:
 - said step (a) includes modulating with a frequency said light beams; and said step (h) includes demodulating at least one of said detector signals and said receiver signals based on said frequency.
- 20 (Original): The method of claim 19, wherein said step (h) includes processing with phase sensitive detection.